

**30V N-Ch Power MOSFET**
**Feature**

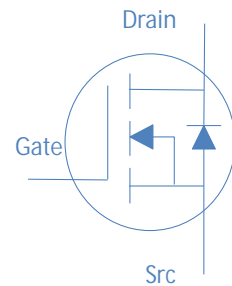
High Speed Power Switching, Logic Level  
 Enhanced Avalanche Ruggedness  
 100% UIS Tested, 100% Rg Tested  
 Lead Free, Halogen Free

$V_{DS}$		30	V
$R_{DS(on),typ}$	$V_{GS}=4.5V$	43	$m\Omega$
$R_{DS(on),typ}$	$V_{GS}=2.5V$	60	$m\Omega$
$I_D$ (Silicon Limited)		3.5	A

**Application**

Hard Switching and High Speed Circuit  
 DC/DC in Telecoms and Industrial

SOT-23



Part Number	Package	Marking
HTJ500N03	SOT23	17

**Absolute Maximum Ratings at  $T_J=25$  (unless otherwise specified)**

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	$I_D$	$T_A=25$	3.5	A
		$T_A=70$	2.4	
Drain to Source Voltage	$V_{DS}$	-	30	V
Gate to Source Voltage	$V_{GS}$	-	$\pm 12$	V
Pulsed Drain Current	$I_{DM}$	-	14	A
Power Dissipation	$P_D$	$T_A=25$	1.04	W
Operating and Storage Temperature	$T_J, T_{stg}$	-	-55 to 150	

**Absolute Maximum Ratings**

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	120	$\text{K/W}$

**Electrical Characteristics at  $T_J=25$  (unless otherwise specified)**
**Static Characteristics**

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	0.45	0.75	1.2	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=24V, T_J=25$	-	-	1	$\mu A$
		$V_{GS}=0V, V_{DS}=20V, T_J=125$	-	-	10	
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
Drain to Source on Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=3.5A$	-	43	50	m $\Omega$
		$V_{GS}=2.5V, I_D=2A$	-	60	80	
Transconductance	$g_{fs}$	$V_{DS}=5V, I_D=3.5A$	-	5	-	S

**Dynamic Characteristics**

Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=10V, f=1MHz$	-	362	-	pF
Output Capacitance	$C_{oss}$		-	52	-	
Reverse Transfer Capacitance	$C_{rss}$		-	39	-	
Total Gate Charge	$Q_g$	$V_{DD}=10V, I_D=3.5A, V_{GS}=4.5V$	-	5.2	-	nC
Gate to Source Charge	$Q_{gs}$		-	1.5	-	
Gate to Drain (Miller) Charge	$Q_{gd}$		-	1.8	-	
Turn on Delay Time	$t_{d(on)}$	$V_{DD}=10V, I_D=1A, V_{GS}=4.5V, R_G=6\Omega,$	-	8	-	ns
Rise time	$t_r$		-	2.5	-	
Turn off Delay Time	$t_{d(off)}$		-	20	-	
Fall Time	$t_f$		-	5	-	

**Reverse Diode Characteristics**

Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_F=2A$	-		1.2	V
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Fig 1. Typical Output Characteristics

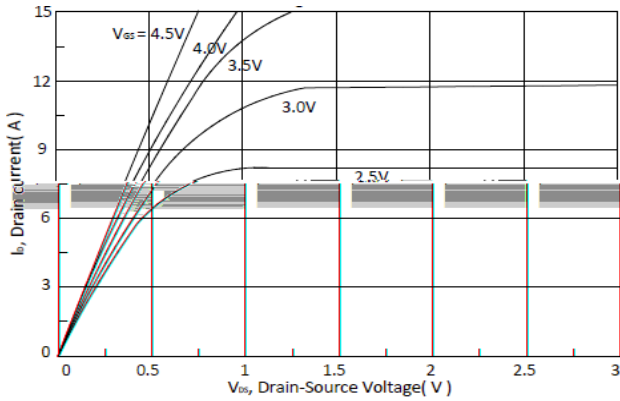


Figure 2. On-Resistance vs. Gate-Source Voltage

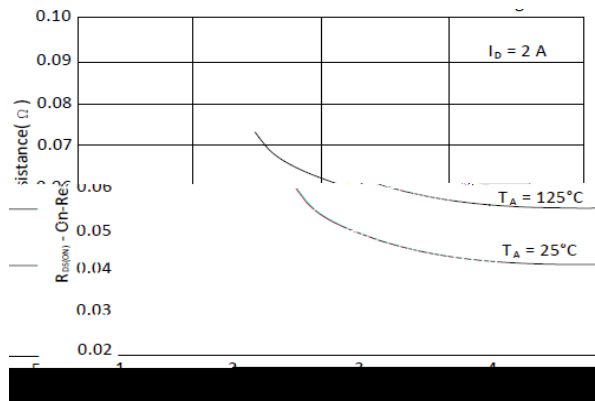


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

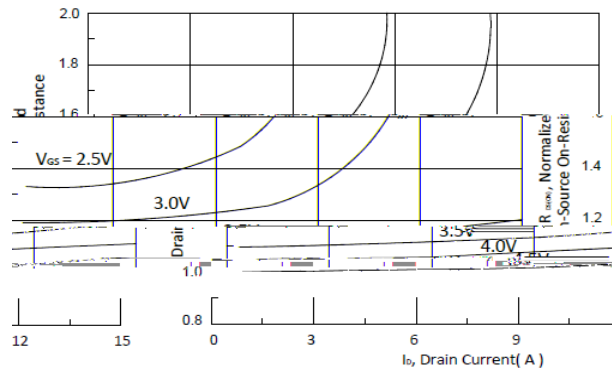


Figure 4. Normalized On-Resistance vs. Junction Temperature

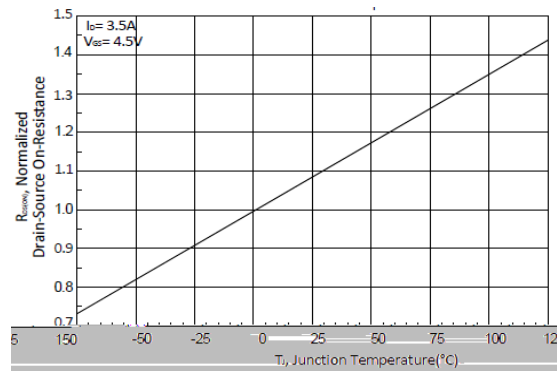


Figure 5. Typical Transfer Characteristics

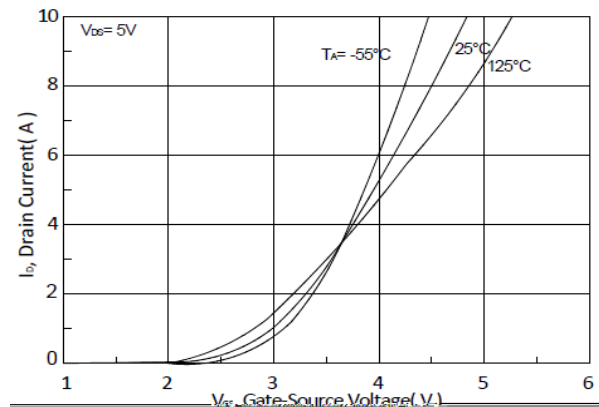


Figure 6. Typical Source-Drain Diode Forward Voltage

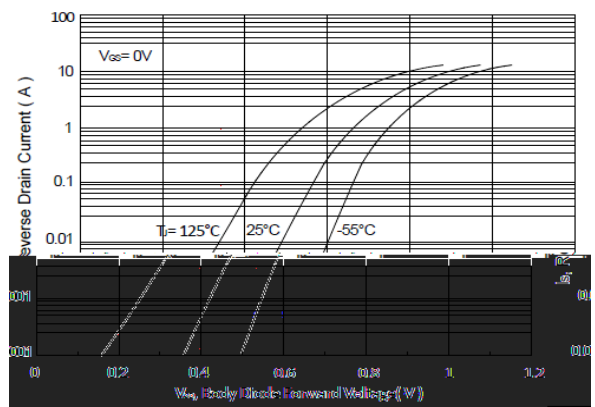


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

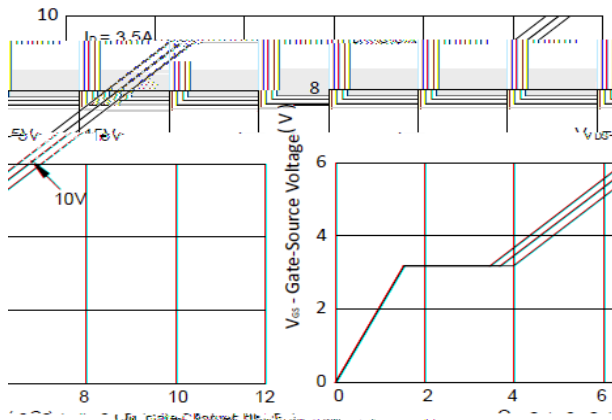


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

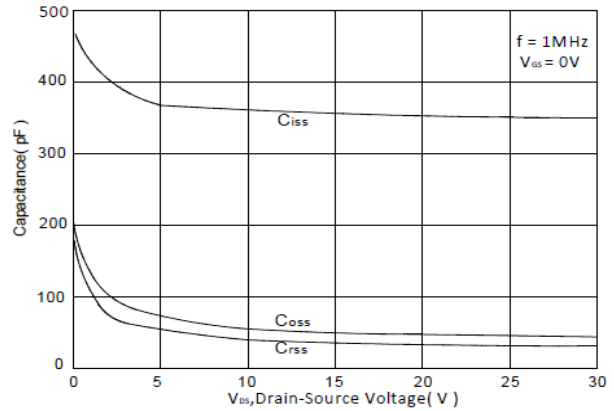


Figure 9. Maximum Safe Operating Area

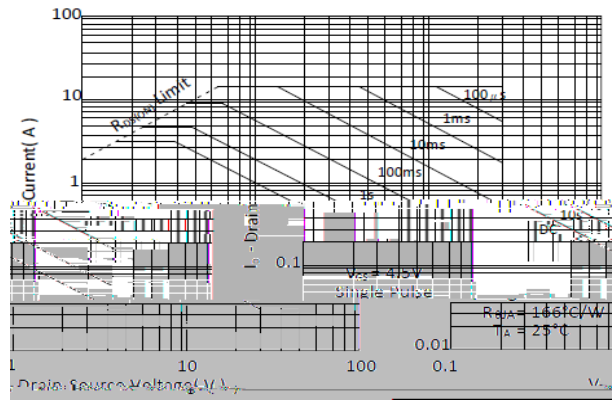


Figure 10. Single Pulse Maximum Power Dissipation

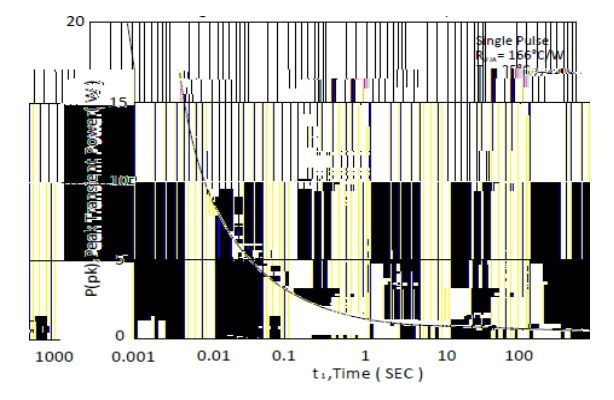
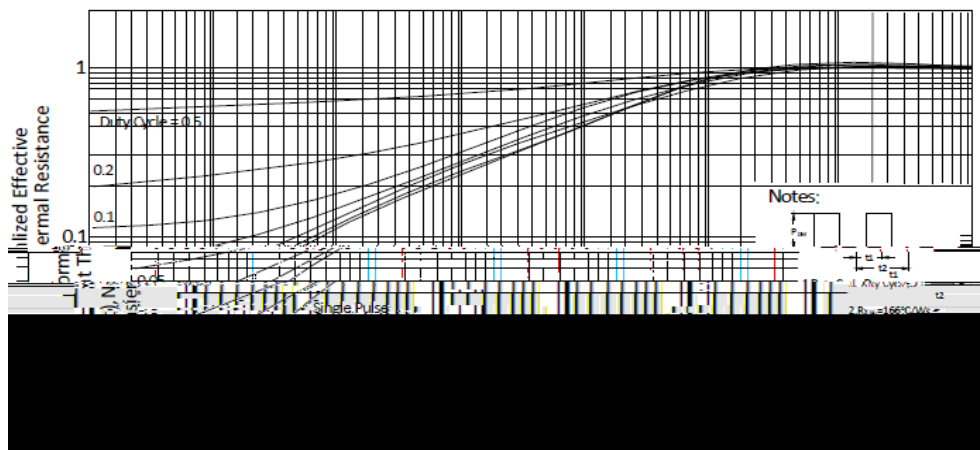
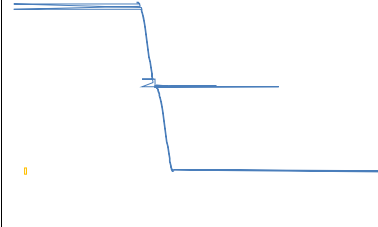


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient



Inductive switching Test



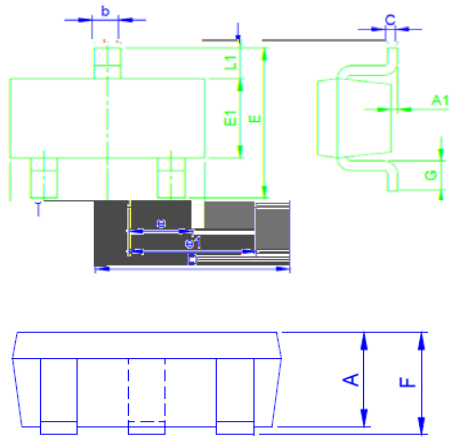
Gate Charge Test

Uclamped Inductive Switching (UIS) Test

Diode Recovery Test

Package Outline

SOT-23, 3leads



Dimension in mm

Dimension	A	A1	b	C	D	E	E1	e	e1	F	G	L1
Min.	0.70	0.2	0.2	0.20	0.20	0.25	0.1	0.20	0.10	0.20	0.20	0.50
0.95	1.9											
1.00		1.25	0.6	0.75								
Typ.										2.90		
Max.					1.15	0.1	0.5	0.20	3.02	3.00	1.7	